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## FQT1N60C

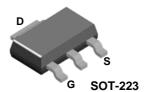
# N-Channel QFET® MOSFET 600V, 0.2 A, 11.5 $\Omega$

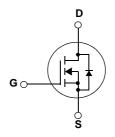
#### **Description**

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce onstate resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### **Features**

- 0.2 A, 600 V,  $R_{DS(on)}$ =9.3  $\Omega(V^{\hat{}}]$ .)@ $V_{GS}$ =10 V,  $I_D$ =0.1 A
- Low Gate Charge (Typ. I È nC)
- Low C<sub>rss</sub> (Typ. HĚ pF)
- 100% Avalanche Tested
- · RoHS Compliant





#### MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted\*

Symbol		Parameter		FQT1N60C	Unit	
V <sub>DSS</sub>	Drain to Source Voltage			600	V	
V <sub>GSS</sub>	Gate to Source Voltage			±30	V	
	Drain Current	-Continuous (T <sub>C</sub> = 25°C)		0.2	А	
ID	Diamourient	-Continuous (T <sub>C</sub> = 100°C)		0.12	A	
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)		0.8	Α	
E <sub>AS</sub>	Single Pulsed Avalanche E	Energy	(Note 2)	33	mJ	
I <sub>AR</sub>	Avalanche Current		(Note 1)	0.2	Α	
E <sub>AR</sub>	Repetitive Avalanche Ener	rgy	(Note 1)	0.2	mJ	
dv/dt	Peak Diode Recovery dv/d	it	(Note 3)	4.5	V/ns	
D	Dower Dissinction	(T <sub>A</sub> = 25°C)		2.1	W	
$P_{D}$	Power Dissipation	- Derate above 25°C		0.02	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Ter	mperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

#### **Thermal Characteristics**

Symbol	Parameter	Min.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient*	-	60	°C/W

<sup>\*</sup> When mounted on the minimum pad size recommended (PCB Mount)

## Package Marking and Ordering Information T<sub>C</sub> = 25°C unless otherwise noted

Device Markin	g D	evice	Package	)	Reel Size	Tape V	Vidth	Quantity	/
FQT1N60C	FQ1	1N60C	SOT-223		330mm	12m	ım	4000	

#### **Electrical Characteristics**

Parameter	Test Conditions	Min.	Тур.	Max.	Unit
cteristics					
Drain to Source Breakdown Voltage	$I_D = 250 \mu A$ , $V_{GS} = 0 V$ , $T_J = 25 ^{\circ} C$	600	-	-	V
Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C	-	0.6	-	V/°C
Zoro Gato Voltago Drain Current	V <sub>DS</sub> = 600V, V <sub>GS</sub> = 0V	-	-	25	μА
Zero Gate Voltage Drain Current	$V_{DS} = 480V, T_{C} = 125^{\circ}C$	-	-	250	μΑ
Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA
	Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current				

#### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.0	-	4.0	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 0.1A$	-	9.3	11.5	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 40V, I_D = 0.1A$ (Note 4)	-	0.75	-	S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V	-	130	170	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$	-	19	25	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	I - IIVII IZ	-	3.5	6	pF
$Q_g$	Total Gate Charge at 10V		-	4.8	6.2	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	$V_{DS} = 480V, I_{D} = 1A$	-	0.7	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10V (Note 4, 5)	5) -	2.7	-	nC

#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	7	24	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 300V, I_{D} = 1A$	-	21	52	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 25\Omega$	-	13	36	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)	-	27	64	ns

#### **Drain-Source Diode Characteristics**

I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current			-	0.2	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current			-	0.8	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	in to Source Diode Forward Voltage $V_{GS}$ = 0V, $I_{SD}$ = 0.2A		-	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 1A	-	190	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (No	te 4) -	0.53	-	μС

#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 59mH, I $_{AS}$  = 1.1A, V $_{DD}$  = 50V, R $_{G}$  = 25 $\Omega$ , Starting T $_{J}$  = 25°C
- 3.  $I_{SD} \le$  0.2A, di/dt  $\le$  200A/ $\mu$ s,  $V_{DD} \le$  BV $_{DSS}$ , Starting  $T_J$  = 25°C
- 4. Pulse Test: Pulse width  $\leq 300 \mu s, \, \text{Duty Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

## **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

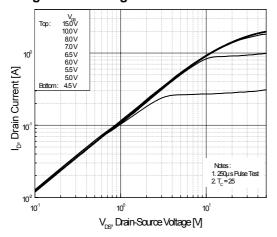


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

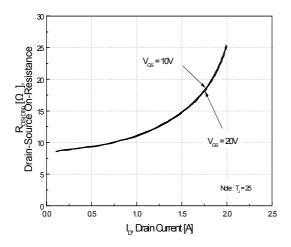


Figure 5. Capacitance Characteristics

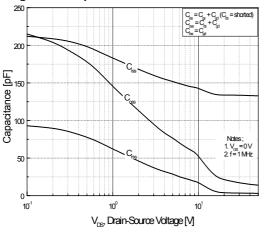


Figure 2. Transfer Characteristics

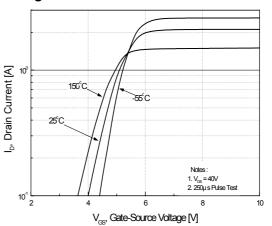


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

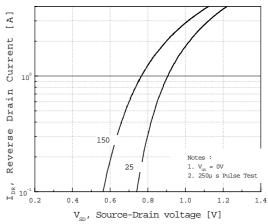
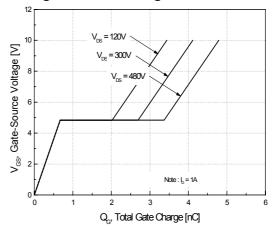


Figure 6. Gate Charge Characteristics



## **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

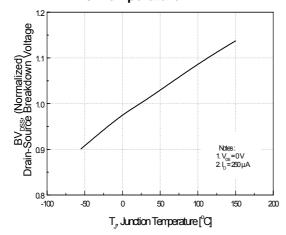


Figure 8. On-Resistance Variation vs. Temperature

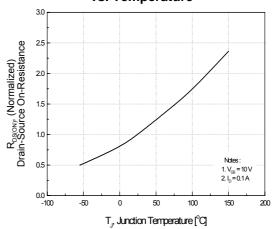


Figure 9. Maximum Safe Operating Area

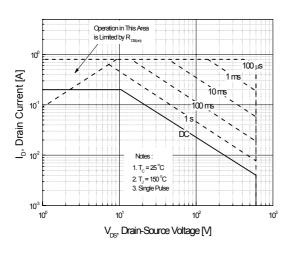


Figure 10. Maximum Drain Current vs. Case Temperature

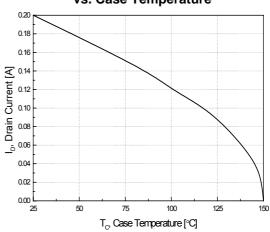
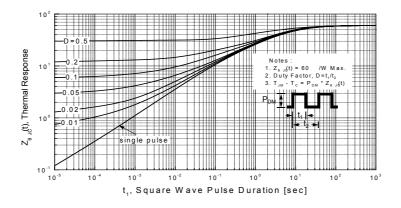
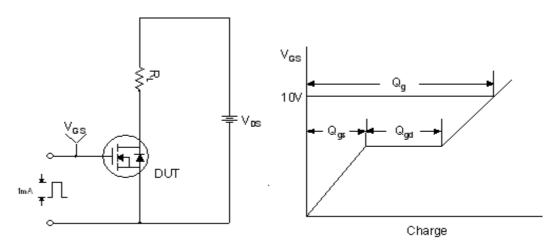


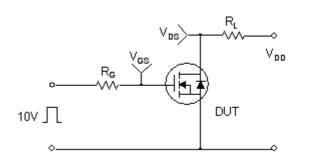
Figure 11. Transient Thermal Response Curve

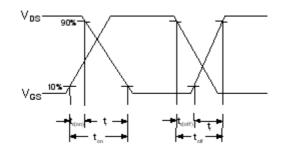


#### **Gate Charge Test Circuit & Waveform**

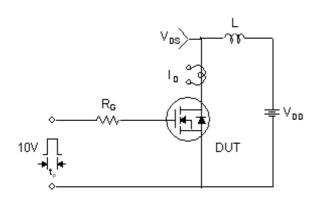


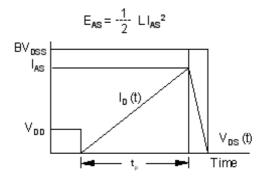
#### **Resistive Switching Test Circuit & Waveforms**



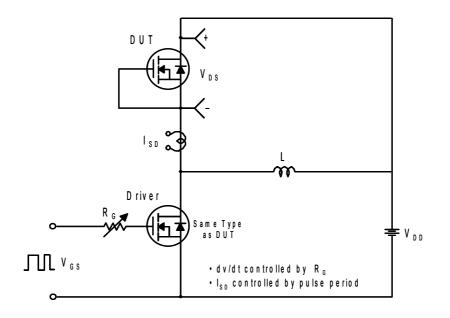


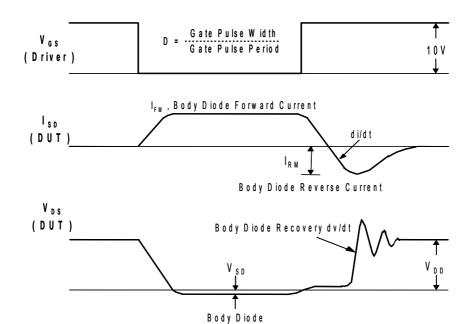
#### **Unclamped Inductive Switching Test Circuit & Waveforms**





#### Peak Diode Recovery dv/dt Test Circuit & Waveforms

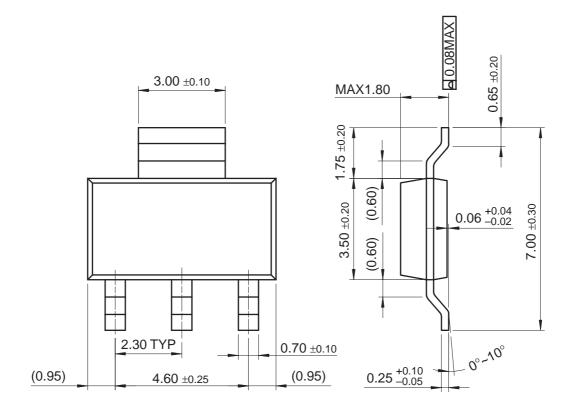


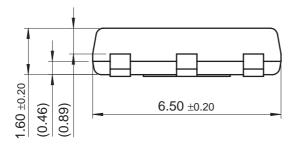


Forward Voltage Drop

### **Mechanical Dimensions**

## **SOT-223**





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